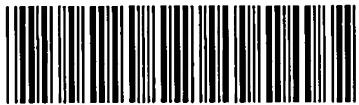


<b>Search Notes</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10541906	FINCH ET AL.
	Examiner	Art Unit
	Le, Hien	3662

### SEARCHED

Class	Subclass	Date	Examiner
342	157.2,194,	12/21/2006	Hien Le
342	163,159-164	8/9/2007	Hien Ly

### SEARCH NOTES

Search Notes	Date	Examiner
Inventor's name search	12/20/2006	Hien Ly
NPL search	12/20/2006	Hien Ly
Plus search	12/20/2006	Hien Ly
Text search	12/20/2006	Hien ly
NPL search (update)	8/8/2007	Hien ly
Text search (update)	8/8/2007	Hien Ly

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner